128K x 8 Bit Static Random Access Memory

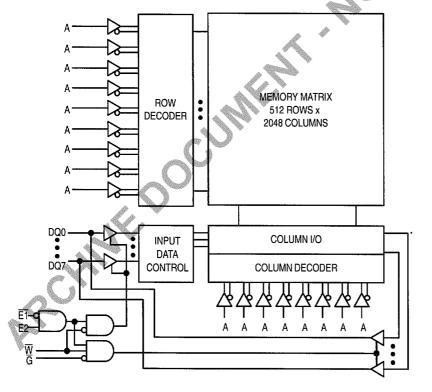
The MCM6226BA is a 1,048,576 bit static random access memory organized as 131,072 words of 8 bits, fabricated using high–performance silicon–gate CMOS technology. Static design eliminates the need for external clocks or timing strobes while CMOS circuitry reduces power consumption and provides for greater reliability.

The MCM6226BA is equipped with both chip enable ($\overline{E1}$ and E2) and output enable (\overline{G}) pins, allowing for greater system flexibility and eliminating bus contention problems.

The MCM6226BA is available in a 400 mil, 32 lead surface-mount SOJ package.

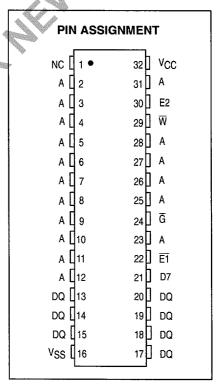
- Single 5 V ± 10% Power Supply
- Fast Access Times: 20/25/35 ns
- · Equal Address and Chip Enable Access Times
- All Inputs and Outputs are TTL Compatible
- · Three State Outputs
- Low Power Operation: 160/140/115 mA Maximum, Active AC

BLOCK DIAGRAM



MCM6226BA





PIN NAMES							
A Address Inputs W Write Enable G Output Enable E1, E2 Chip Enables DQ Data Inputs/Outputs NC No Connection VCC + 5 V Power Supply							
V _{SS} Ground							

REV 1 1/10/96

TRUTH TABLE

Ē1	E2	G	W	Mode	I/O Pin	Cycle	Current
Н	Х	Х	Х	Not Selected	High-Z	_	ISB1, ISB2
X	L	Х	Х	Not Selected	High-Z		ISB1, ISB2
L	Н	Н	Н	Output Disabled	High-Z		ICCA
L	Н	L	Н	Read	D _{out}	Read	ICCA
L	Н	Х	L.	Write	D _{in}	Write	ICCA

H = High, L = Low, X = Don't Care

ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Power Supply Voltage Relative to VSS	Vcc	- 0.5 to 7.0	V
Voltage Relative to VSS for Any Pin Except VCC	V _{in} , V _{out}	- 0.5 to V _{CC} + 0.5	٧
Output Current (per I/O)	lout	± 20	mA
Power Dissipation	PD	1.0	W
Temperature Under Bias	T _{bias}	- 10 to + 85	°C
Operating Temperature	TA	0 to + 70	°C
Storage Temperature	T _{stg}	- 55 to + 150	°C

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to these high-impedance circuits.

This CMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow of at least 500 linear feet per minute is maintained.

DC OPERATING CONDITIONS AND CHARACTERISTICS

 $(V_{CC} = 5.0 \text{ V} \pm 10\%, T_A = 0 \text{ to } 70^{\circ}\text{C}, \text{ Unless Otherwise Noted})$

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Max	Unit
Supply Voltage (Operating Voltage Range)	Vcc	4.5	5.5	٧
Input High Voltage	VIH	2.2	V _{CC} + 0.3**	٧
Input Low Voltage	V _{IL}	- 0.5*	0.8	٧

^{*} V_{IL} (min) = -0.5 V dc; V_{IL} (min) = -2.0 V ac (pulse width \leq 20 ns).

DC CHARACTERISTICS AND SUPPLY CURRENTS

Parameter		Symbol	Min	Max	Unit
Input Leakage Current (All Inputs, Vin = 0 to VCC)		llkg(l)	_	± 1	μА
Output Leakage Current ($\overline{E}^* = V_{IH}$, $V_{out} = 0$ to V_{CC})		llkg(O)	_	±1	μА
AC Active Supply Current ($I_{Out} = 0 \text{ mA}$, all inputs = V_{IL} or V_{IH} , $V_{IL} = 0$, $V_{IH} \ge 3 \text{ V}$, cycle time $\ge t_{AVAV}$ min, $V_{CC} = \text{max}$)	MCM6226BA-20: t _{AVAV} = 20 ns MCM6226BA-25: t _{AVAV} = 25 ns MCM6226BA-35: t _{AVAV} = 35 ns	ICCA		150 130 120	mA
AC Standby Current (V _{CC} = max, \overline{E}^* = V _{IH} , f = f _{max})	MCM6226BA-20: t_{AVAV} = 20 ns MCM6226BA-25: t_{AVAV} = 25 ns MCM6226BA-35: t_{AVAV} = 35 ns	I _{SB1}	_ _ _	35 30 25	mA
CMOS Standby Current ($\overline{E}^* \ge V_{CC} - 0.2 \text{ V}, V_{in} \le V_{SS}$ or $\ge V_{CC} - 0.2 \text{ V}, V_{CC} = \text{max}, f = 0 \text{ MHz}$)	+ 0.2 V	ISB2	_	5	mA
Output Low Voltage (I _{OL} = + 8.0 mA)		VOL		0.4	V
Output High Voltage (I _{OH} = - 4.0 mA)		VOH	2.4	_	٧

^{*} $\overline{E1}$ and E2 are represented by \overline{E} in this data sheet. E2 is of opposite polarity to $\overline{E1}$.

^{**} V_{IH} (max) = V_{CC} + 0.3 V dc; V_{IH} (max) = V_{CC} + 2 V ac (pulse width \leq 20 ns).

CAPACITANCE (f = 1.0 MHz, dV = 3.0 V, T_A = 25°C, Periodically Sampled Rather Than 100% Tested)

	Symbol	Тур	Max	Unit	
Input Capacitance	All Inputs Except Clocks and DQs $\overline{\text{E1}}$, E2, $\overline{\text{G}}$, and $\overline{\text{W}}$	C _{in} C _{ck}	4 5	6 8	pF
I/O Capacitance	DQ	C _{I/O}	5	8	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS

 $(V_{CC} = 5.0 \text{ V} \pm 10\%, T_A = 0 \text{ to} + 70^{\circ}\text{C}, \text{Unless Otherwise Noted})$

Input Pulse Levels 0 to 3.0 V	Output Timing Measurement Reference Level 1.5 V
Input Rise/Fall Time	Output Load See Figure 1A
Input Timing Measurement Reference Level 1.5 V	

READ CYCLE TIMING (See Notes 1, 2, and 3)

		MCM62	MCM6226BA-20 MCM6226BA-25 MCM6226BA-35		6BA-35				
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Read Cycle Time	†AVAV	20		25		35	_	ns	4
Address Access Time	†AVQV	_	20		25	> —	35	ns	
Enable Access Time	†ELQV		20	- 4	25		35	ns	5
Output Enable Access Time	tGLQV		7	+	≫ 8	_	8	ns	
Output Hold from Address Change	tAXQX	5	— ,	5	_	5	_	ns	
Enable Low to Output Active	†ELQX	5		-5		5	_	ns	6, 7, 8
Output Enable Low to Output Active	tGLQX	0		0		0	_	ns	6, 7, 8
Enable High to Output High–Z	t _{EHQZ}	0 1	7	0	8	0	8	ns	6, 7, 8
Output Enable High to Output High-Z	t _{GHQZ}	0	7	0	8	0	8	ns	6, 7, 8

NOTES:

- 1. W is high for read cycle.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. $\overline{E1}$ and E2 are represented by \overline{E} in this data sheet. E2 is of opposite polarity to $\overline{E1}$.
- 4. All timings are referenced from the last valid address to the first transitioning address.
- 5. Addresses valid prior to or coincident with E going low.
- 6. At any given voltage and temperature, teHQZ max is less than teLQX min, and tGHQZ max is less than tGLQX min, both for a given device and from device to device.
- 7. Transition is measured $\pm\,500$ mV from steady–state voltage with load of Figure 1B.
- 8. This parameter is sampled and not 100% tested.
- 9. Device is continuously selected ($\overline{E} \le V_{|L}$, $\overline{G} \le V_{|L}$).

AC TEST LOADS

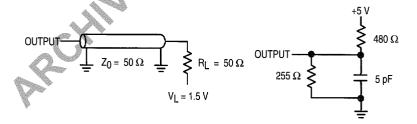


Figure 1A

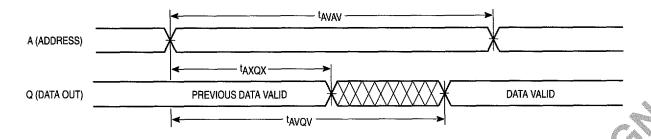
Figure 1B

TIMING LIMITS

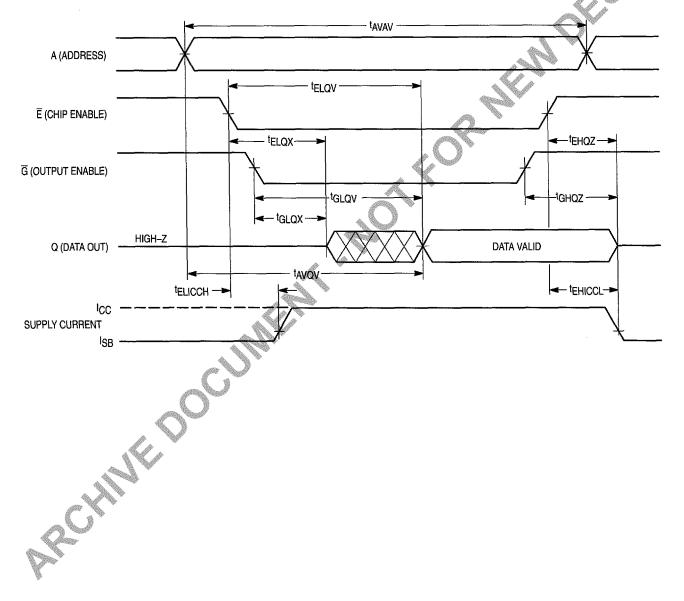
The table of timing values shows either a minimum or a maximum limit for each parameter. Input requirements are specified from the external system point of view. Thus, address setup time is shown as a minimum since the system must supply at least that much time (even though most devices do not require it). On the other hand, responses from the memory are specified from the device point of view. Thus, the access time is shown as a maximum since the device never provides data later than that time.

3

READ CYCLE 1 (See Notes 1, 2, 3, and 9)



READ CYCLE 2 (See Notes 3 and 5)



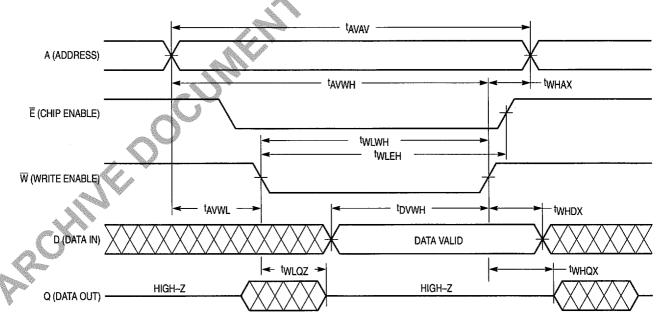
WRITE CYCLE 1 (W Controlled, See Notes 1, 2, 3, and 4)

		MCM622	6BA-20	MCM6226BA-25		MCM6226BA-25 MCM6226BA-35		26BA-35		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes	
Write Cycle Time	^t AVAV	20		25	_	35	_	ns	5	
Address Setup Time	†AVWL	0	_	0	_	0	_	ns		
Address Valid to End of Write	^t AVWH	15		17	_	20	_	ns		
Write Pulse Width	^t WLWH, ^t WLEH	15	_	17		20	_	ns		
Data Valid to End of Write	^t DVWH	9	_	10		11	_	ns		
Data Hold Time	twhox	0	_	0	_	0	-, (ns		
Write Low to Data High-Z	tWLQZ	0	7	0	8	0	- 8	ns	6, 7, 8	
Write High to Output Active	tWHQX	5	_	5		5	+	ns	6, 7, 8	
Write Recovery Time	tWHAX	0	_	0		0		ns		

NOTES:

- 1. A write occurs during the overlap of \overline{E} low and \overline{W} low.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. $\overline{E1}$ and E2 are represented by \overline{E} in this data sheet. E2 is of opposite polarity to $\overline{E1}$.
- 4. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high-impedance state.
- 5. All timings are referenced from the last valid address to the first transitioning address.
- 6. Transition is measured ± 500 mV from steady-state voltage with load of Figure 1B.
- 7. This parameter is sampled and not 100% tested.
- 8. At any given voltage and temperature, twLOZ max is less than twHOX min both for a given device and from device to device.

WRITE CYCLE 1 (W Controlled See Notes 1, 2, 3, and 4)



MOTOROLA FAST SRAM MCM6226BA

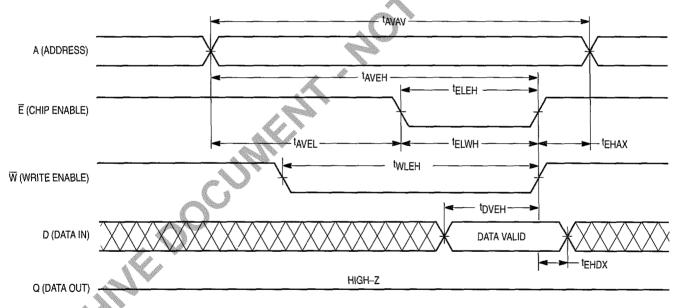
WRITE CYCLE 2 (E Controlled, See Notes 1, 2, 3, and 4)

		MCM622	16226BA-20 MCM6226BA-25		MCM622	6BA-35			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	tAVAV	20		25	_	35	_	ns	5
Address Setup Time	tAVEL	0		0		0	_	ns	
Address Valid to End of Write	t _{AVEH}	15	_	17	_	20	_	ns	
Enable to End of Write	^t ELEH, ^t ELWH	15		17	_	20	_	ns	6, 7
Write Pulse Width	tWLEH	15	_	17	-	20	_	ns	
Data Valid to End of Write	†DVEH	9		10	_	11	_	ns	
Data Hold Time	tEHDX	0		0	_	0		ns	
Write Recovery Time	t _{EHAX}	0		0	_	0	-	ns	

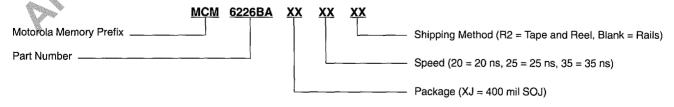
NOTES:

- 1. A write occurs during the overlap of \overline{E} low and \overline{W} low.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. E1 and E2 are represented by E in this data sheet. E2 is of opposite polarity to E1.
- 4. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high-impedance state.
- 5. All timings are referenced from the last valid address to the first transitioning address.
- 6. If E goes low coincident with or after W goes low, the output will remain in a high-impedance state.
- 7. If E goes high coincident with or before W goes high, the output will remain in a high-impedance state.

WRITE CYCLE 2 (E Controlled See Notes 1, 2, 3, and 4)



ORDERING INFORMATION (Order by Full Part Number)



Full Part Numbers — MCM6226BAXJ20

MCM6226BAXJ20R2

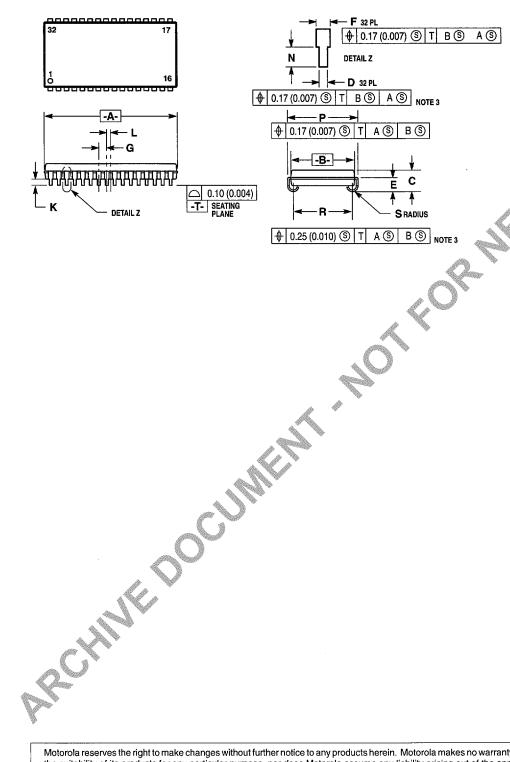
MCM6226BAXJ25

MCM6226BAXJ25R2

MCM6226BAXJ35

MCM6226BAXJ35R2

32 LEAD 400 MIL SOJ CASE 857A-02



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- TO BE DETERMINED AT PLANE -T-.
 DIMENSION A & B DO NOT INCLUDE MOLD PROTRUSION. MOLD PROTRUSION SHALL NOT
- EXCEED 0.15 (0.006) PER SIDE.
 DIMENSION A & B INCLUDE MOLD MISMATCH AND ARE DETERMINED AT THE PARTING LINE.

			3059	1000		
	MILLIM	ETERS	NC.	HES		
DIM	MIN	MAX	Z	MAX		
Α	20.83	21.08	0.820	0.830		
В	10.03	10.29	0.395	0.405		
C	3.26	3.75	0.128	0.148		
D	0.41	0.50	0.016	0.020		
E 🦪	2.24	2.48	0.088	0.098		
_aF	0.67	0.81	0.026	0.032		
G	1.27	BSC	0.050 BSC			
K	0.89	1.14	0.035	0.045		
₹ L.	0.64	BSC	0.02	BSC		
N	0.76	1.14	0.030	0.045		
P	11.05	11.30	0.435	0.445		
R	9.27	9.52	0.365	0.375		
S	0.77	1.01	0.030	0.040		

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